

Search Notes



Application/Control No.

10/821,581

Examiner

Patricia Leith

**Applicant(s)/Patent under
Reexamination**

NAIR, MURAL

1655

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST;JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE	9/7/2007	PL
Inventor name search PALM/EAST	9/7/2007	PL
Reviewed all parent cases (reviewed what was on eDAN and previous rejections saved in my files)	9/7/2007	PL